

FORM PTO-1449  
(REV. 7-80)  
(Title Amended 3/83)

U.S. DEPARTMENT OF COMMERCE  
PATENT AND TRADEMARK OFFICE

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RD-28,389-8

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10/727,401

INFORMATION DISCLOSURE STATEMENT BY APPLICANT--  
LIST OF ITEMS

(Use several sheets if necessary)

Applicant

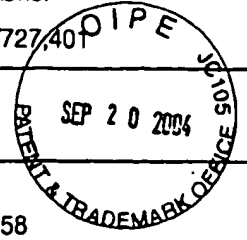
Yuri Alexeyevich Plotnikov et al.

Filing Date

December 3, 2003

Group

2858



## U.S. PATENT DOCUMENTS

*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
JT	AA 3 8 7 5 5 0 2	04/01/75	Neumaier	324	241	
JT	AB 4 2 9 2 5 8 9	09/29/81	Bonner	324	221	
JT	AC 4 4 9 5 4 6 6	01/22/85	Lakin	324	242	
JT	AD 5 0 5 6 0 4 9	10/08/91	O'Neill	702	55	
JT	AE 5 3 9 1 9 8 8	02/21/95	Kitagawa	324	225	
JT	AF 5 4 3 4 5 0 6	07/18/95	Flora	324	242	
JT	AG 5 4 9 1 4 0 9	02/13/96	Flora et al.	324	242	
JT	AH 6 1 2 4 7 1 2	09/26/00	Chaiken	324	326	
JT	AI 6 2 5 9 8 2 6	07/10/01	Pollard et al.	382	284	
JT	AJ 6 3 6 6 0 8 5	04/02/02	Yeshurun et al.	324	263	
	AK					

## FOREIGN PATENT DOCUMENTS

	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
						YES	No
JT	AL 0 5 3 3 0 4 4 0	09/15/92	EP	—	—	English	
JT	AM 0 5 1 2 7 9 6	05/05/92	EP	—	—	English	
	AN						
	AO						
	AP						

## OTHER INFORMATION (Including Author, Title, Date, Pertinent pages. Etc.)

JT	AR	R. Rempt, "Scanning with Magnetoresistive Sensors for Subsurface Corrosion, Review of Progress in Quantitative Nondestructive Evaluation, Vol. 21, 2002 American Institute of Physics, pp. 1771-1778.
JT	AS	Y. A. Plotnikov et al., "Defect Characterization in Multi-Layered Conductive Components with Pulsed Eddy Current, Vol. 21, 2002 American Institute of Physics, pp. 1976-1983.
	AT	

EXAMINER

DATE CONSIDERED

1/5/05

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.